

### **SD56120M**

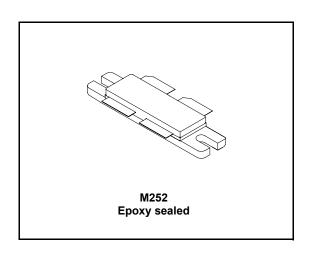
# RF POWER Transistors, LDMOST plastic family N-Channel enhancement-mode lateral MOSFETs

#### **General features**

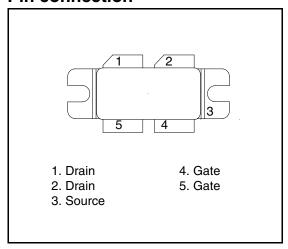
- Excellent thermal stability
- Common source configuration Push-pull
- $\blacksquare$  P<sub>OUT</sub> = 120W with 13dB gain @ 860MHz / 32V
- BeO free package
- Internal input matching

#### **Description**

The SD56120M is a common source N-Channel enhancement-mode lateral Field-Effect RF power transistor designed for broadband commercial and industrial applications at frequencies up to 1.0 GHz. The SD56120M is designed for high gain and broadband performance operating in common source mode at 32 V. Its internal matching makes it ideal for TV broadcast applications requiring high linearity.



#### Pin connection



#### **Order codes**

Part number	Package	Branding
SD56120M	M252	SD56120M

July 2006 Rev 10 1/14

Contents SD56120M

## **Contents**

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SD56120M Electrical data

## 1 Electrical data

## 1.1 Maximum ratings

Table 1. Absolute maximum ratings  $(T_{CASE} = 25^{\circ}C)$ 

Symbol	Parameter	Value	Unit
V <sub>(BR)DSS</sub>	Drain-Source Voltage	65	V
$V_{GS}$	Gate-Source Voltage	±20	V
I <sub>D</sub>	Drain Current	14	Α
P <sub>DISS</sub>	Power Dissipation (@ Tc = 70°C)	236	W
Tj	Max. Operating Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	-65 to +150	°C

### 1.2 Thermal data

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thJC</sub>	Junction - case thermal resistance	0.55	°C/W

Electrical characteristics SD56120M

## 2 Electrical characteristics

$$T_{CASE} = +25$$
 °C

#### 2.1 Static

Table 3. Static (per section)

Symbol	Test conditions				Тур	Max	Unit
V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V	I <sub>DS</sub> = 10 mA		65			V
I <sub>DSS</sub>	$V_{GS} = 0 V$	V <sub>DS</sub> = 28 V				1	μΑ
I <sub>GSS</sub>	V <sub>GS</sub> = 20 V	$V_{DS} = 0 V$				1	μΑ
$V_{GS(Q)}$	V <sub>DS</sub> = 28 V	$I_D = 100 \text{ mA}$		2.0		5.0	V
V <sub>DS(ON)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 3 A			0.7	0.8	V
G <sub>FS</sub>	V <sub>DS</sub> = 10 V	I <sub>D</sub> = 3 A			3		mho
C <sub>ISS</sub> <sup>(1)</sup>	$V_{GS} = 0 V$	V <sub>DS</sub> = 28 V	f = 1 MHz		221		pF
C <sub>OSS</sub>	$V_{GS} = 0 V$	V <sub>DS</sub> = 28 V	f = 1 MHz		48.9		pF
C <sub>RSS</sub>	$V_{GS} = 0 V$	V <sub>DS</sub> = 28 V	f = 1 MHz		2.25		pF

<sup>1.</sup> Includes Internal Input Moscap.

## 2.2 Dynamic

Table 4. Dynamic

Symbol	Test co	Test conditions			Max	Unit
P <sub>OUT</sub>	$V_{DD} = 32V  I_{DQ} = 400 \text{ mA}$	f = 860MHz	120			W
G <sub>PS</sub>	$V_{DD} = 32V I_{DQ} = 400 \text{ mA}$	P <sub>OUT</sub> = 120 W,f = 860MHz	13	16		dB
h <sub>D</sub>	$V_{DD} = 32V I_{DQ} = 400 \text{ mA}$	P <sub>OUT</sub> = 120 W,f = 860MHz	50			%
Load mismatch	$V_{DD} = 32V I_{DQ} = 400 \text{ mA}$ All phase angles	P <sub>OUT</sub> = 120 W,f = 860MHz	10:1			VSWR

SD56120M Impedances

## 3 Impedances

Figure 1. Current conventions

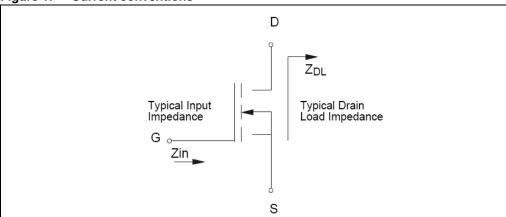


Table 5. Impedance data

Freq. (MHz)	<b>Z</b> <sub>IN</sub> (Ω)	<b>Z</b> <sub>DL</sub> (Ω)
860 MHz	5.57 + j 3.488	4.21 - j 2.88

Note: Measured drain to drain and gate to gate respectively.

Typical performance SD56120M

## 4 Typical performance

Figure 2. Capacitance vs drain voltage

Figure 3. Gate-source voltage vs case temperature

ID = 3 A

80

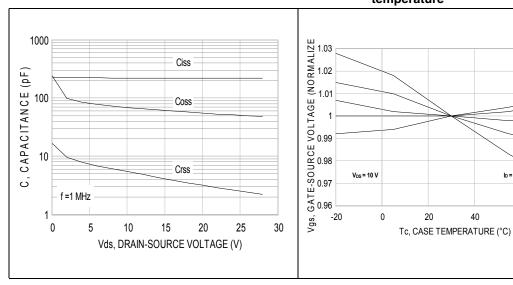


Figure 4. Drain current vs gate voltage

Figure 5. Output power & efficiency vs input power

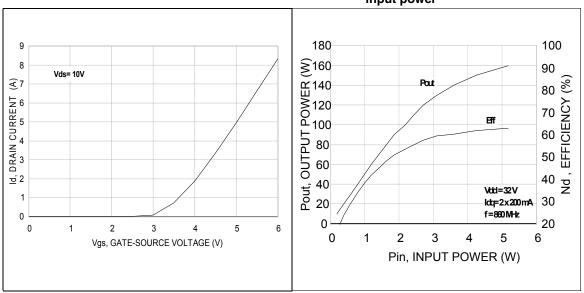
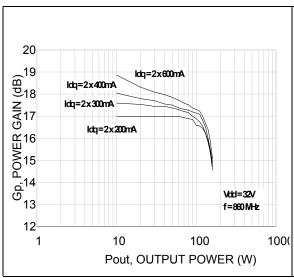


Figure 6. Power gain vs output power

Figure 7. Intermodulation distortion vs output power



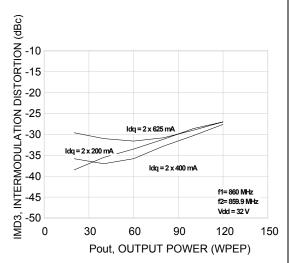
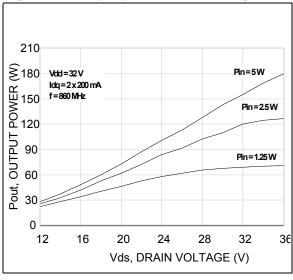


Figure 8. Output power vs drain voltage



Test dira

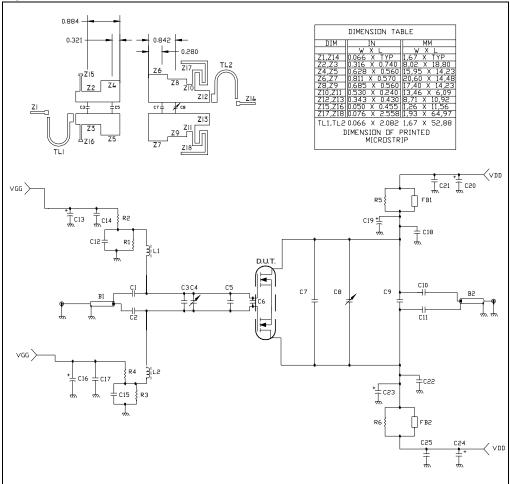


Figure 9. Test circuit schematic

- 1 C3 and C4 adjacent to each other
- 2 Gap between ground & transmission line = 0.056 [1.42] TYP.

**\_\_\_\_\_\_** 

Table 6. Test circuit component part list

Component	Description
C1, C2, C10, C11	51 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C3	9.1 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C4, C8	0.6 - 4.5 GIGATRIM VARIABLE CAPACITOR
C5, C9	5.6 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C6	12 pF ATC 100A SURFACE MOUNT CERAMIC CHIP CAPACITOR
C7	13 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C12, C15, C18, C22	91 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C13, C16, C20, C24	10 μF 50V ALUMINUM ELECTROLYTIC RADIAL LEAD CAPACITOR
C14, C17, C21, C25	0.1 μF 500V SURFACE MOUNT CERAMIC CHIP CAPACITOR
C19, C23	100 μF 63V ALUMINUM ELECTROLYTIC RADIAL LEAD CAPACITOR
R1, R2, R3, R4	200 OHM 1/4 W SURFACE MOUNT CHIP RESISTOR
R5, R6	1.8 OHM 1/4 W SURFACE MOUNT CHIP RESISTOR
B1, B2	BALUN, 25 OHM SEMI-RIDGE OD="0.141", 2.37 LG COAXIAL CABLE OR EQUIVALENT
L1, L2	CHIP INDICATOR 10 nH SURFACE MOUNT COIL
FB1, FB2	SURFACE MOUNT EMI SHIELD BEAD
PCB	WOVEN GLASS REINFORCED / CERAMIC FILLED 0.030" THK $\epsilon r$ = 3.48, 2 Oz ED CU BOTH SIDES

Figure 10. Test fixture

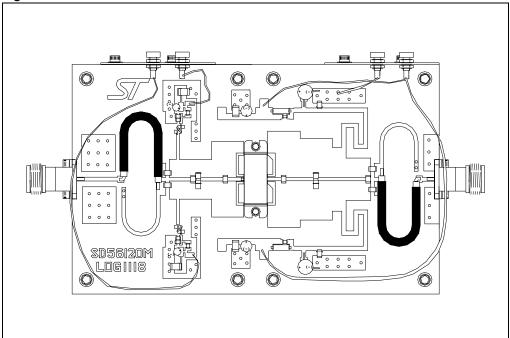
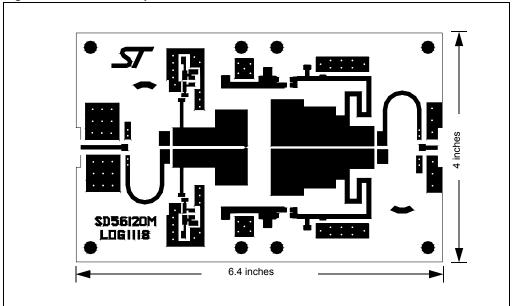


Figure 11. Test circuit photomaster



## 5 Package mechanical data

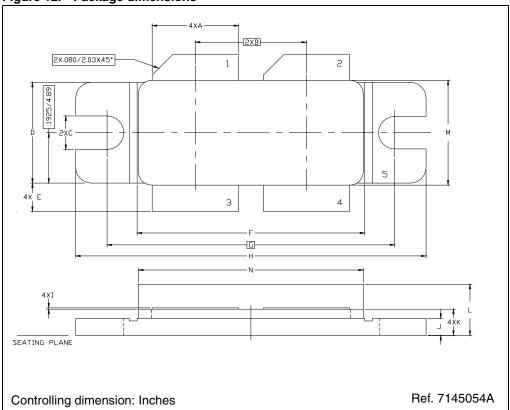
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Table 7. M252 (.400 x .860 4L BAL N/HERM W/FLG) mechanical data

Dim.		mm.			Inch	
	Min	Тур	Max	Min	Тур	Max
Α	8.13		8.64	.320		.340
В		10.80			.425	
С	3.00		3.30	.118		.130
D	9.65		9.91	.380		.390
Е	2.16		2.92	.085		.115
F	21.97		22.23	.865		.875
G		27.94			1.100	
Н	33.91		34.16	1.335		1.345
I	0.10		0.15	.004		.006
J	1.52		1.78	.060		.070
K	2.36		2.74	.093		.108
L	4.57		5.33	.180		.210
М	9.96		10.34	.392		.407
N	21.64		22.05	.852		.868

Figure 12. Package dimensions



SD56120M Revision history

## 6 Revision history

Table 8. Revision history

Date	Revision	Changes
13-Jul-2006	10	New template, added lead free info

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